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APPLICATION NO.	FI	LING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/772,932	10/772,932 02/04/2004		Chunchieh Huang	M-15327 US	6068	
32605	7590	09/12/2005		EXAMINER		
		VOK CHEN & H DRIVE, SUITE 2	LUU, CH	LUU, CHUONG A		
SAN JOSE, CA 95110				ART UNIT	PAPER NUMBER	
				2818		

DATE MAILED: 09/12/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)					
Office Action Comments	10/772,932	HUANG ET AL.					
Office Action Summary	Examiner	Art Unit					
	Chuong A. Luu	2818					
The MAILING DATE of this communication appeariod for Reply	opears on the cover sheet with the c	orrespondence address					
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 03 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).							
Status							
1) Responsive to communication(s) filed on 27.	<u>June 2005</u> .						
2a) This action is FINAL . 2b) ⊠ Th	is action is non-final.						
3) Since this application is in condition for allow closed in accordance with the practice under							
Disposition of Claims	,						
4) ☐ Claim(s) 1-18 is/are pending in the application 4a) Of the above claim(s) 12-18 is/are withdra 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-11 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and are	awn from consideration.						
Application Papers		·					
9) The specification is objected to by the Examir	ner.						
The drawing(s) filed on is/are: a)□ accepted or b)□ objected to by the Examiner.							
Applicant may not request that any objection to th	e drawing(s) be held in abeyance. See	∋ 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the corre		,					
Priority under 35 U.S.C. § 119							
12) ☐ Acknowledgment is made of a claim for foreig a) ☐ All b) ☐ Some * c) ☐ None of: 1. ☐ Certified copies of the priority documer 2. ☐ Certified copies of the priority documer 3. ☐ Copies of the certified copies of the pri application from the International Bure. * See the attached detailed Office action for a list	nts have been received. Its have been received in Applicationity documents have been received au (PCT Rule 17.2(a)).	on No ed in this National Stage					
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date 6/13/05:2/4/04	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:						

DETAILED ACTION

Election/Restrictions

Applicant's election of Group I, claims 1-11 in the reply filed on June 27, 2005 is acknowledged. Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)).

PRIOR ART REJECTIONS

Statutory Basis

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

The Rejections

Claims 1 and 3-11 are rejected under 35 U.S.C. 102(b) as being anticipated by Ha (U.S. 6,451,708 B1).

Ha discloses a semiconductor device with

(1) (i) forming a first layer comprising a first portion and a second portion, wherein the first portion is to provide a first feature of the integrated circuit, and the second portion physically contacts the first portion at the location of the first feature;

(ii) forming a first mask over the first layer, the first mask overlying the first portion but having an opening over the second portion;

- (iii) etching the second portion selectively to the first mask to at least partially remove the second portion;
- (iv) forming a second mask over the first layer, the second mask covering the first and second portions;
- (v) etching the first layer selectively to the second mask, wherein the etching of the first layer comprises lateral etching of the first layer (see Figure 2C);
- (3) wherein the etching operation (iii) comprises anisotropic etching of the second portion (see column 1, lines 31-40);
- (4) further comprising, before forming the first layer, forming at least one first structure projecting upward over a semiconductor substrate in the integrated circuit;

wherein the first and second portions are sidewall spacers formed over a sidewall or sidewalls of the first layer (see Figure 2C);

(5) further comprising, before forming the first layer, forming at least one first structure projecting upward over a semiconductor substrate in the integrated circuit, each first structure comprising a first sidewall and a second sidewall;

wherein the first portion of the first layer overlays the first sidewall of the first structure;

wherein the first layer further comprises a third portion over the second sidewall of the first structure;

wherein the operation (v) removes the third portion (see Figure 2C);

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(6) wherein the operation (i) comprises anisotropically etching the first layer to form spacers over the first and second sidewalls of the first structure (see column 1, lines 31-40);

- (7) wherein the first and second sidewalls are dielectric sidewalls (see Figure2C);
- (8) wherein the integrated circuit comprises an additional feature at least partially patterned by the etching operation (iii) (see Figure 2C);
 - (9) wherein the additional feature is a transistor gate (see Figure 2C);
- (10) wherein the operation (iii) removes the second portion only partially (see Figure 2C);
 - (11) wherein the first portion is conductive (see column 3, lines 23-40).

PRIOR ART REJECTIONS

Statutory Basis

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The Rejections

Claim 2 is rejected under 35 U.S.C. 103(a) as being unpatentable over Ha (U.S. 6,451,708 B1) in view of Wang (U.S. 6,541,324 B1).

Ha teaches the above outlined features except for using isotropic etching to remove the first layer. However, Wang discloses a memory array with (2) wherein the operation (v) is isotropic etching of the first layer (see column 9, lines 40-53). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the teaching of Ha (in accordance with the teaching of Wang). Doing so would facilitate the manufacture of the semiconductor device and reduce the roughness surface of the semiconductor layer.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chuong A. Luu whose telephone number is (571) 272-1902. The examiner can normally be reached on M-F (6:15-2:45).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David C. Nelms can be reached on (571) 272-1787. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

> Chuong Anh Luu Patent Examiner

July 25. 2005